



SHEET 1 OF 9

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

 ATTY. DOCKET NO.
070456-0122

 SERIAL NO.
10/585,646

 APPLICANT
Yasuyuki WATANABE, et al.

 FILING DATE
July 07, 2006

 GROUP
Not Yet Assigned

(Substitute for form 1449/PTO)

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EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code(s) (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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 EXAMINER
 /Thomas R. Hannon/

 DATE CONSIDERED
 01/15/2009

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SHEET 2 OF 9

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EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			
		JIS Z 2242 "Method of impact test for metallic materials", Published by Japanese Standards Association, December 21, 1998			
		JIS Z 2202 "Test pieces for impact test for metallic materials" Published by Japanese Standards Association, February 20, 1998			
		BURRIER, JR., H., "Hardenability of Carbon and Low-Alloy Steels", 2002, ASM International			
		VANDER VOORT, G., "Embrittlement of Steels", 2002 ASM International			
		KIM, C., et al., "Influence of Subzero and Shot-Peening Treatments on Impact and Fatigue Fracture Properties of Case-Hardened Steels", J. Heat Treat., June 1981, Pages 43-53, Vol 2 No 1			
		US Office Action, issued in US Patent Application No. 10/686,766, dated on November 7, 2007			
		US Office Action, issued in US Patent Application No. 10/787,221, dated on October 26, 2007			
EXAMINER /Thomas R. Hannon/			DATE CONSIDERED 01/15/2009		

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